

Notice of References Cited

Application/Control No.

09/922,411

Applicant(s)/Patent Under

Reexamination

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Examiner

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Kashyap, "An expert system for predicting radiated EMI form PCB's". IEEE, 1997, pgs. 444-449.
	V	Marano, "Field tests on telecommunication systems: an evaluation of the radiated emissions by near field probe". IEEE, 1998, pgs. 918-923.
	W	Childs, "Fast interactive EMC analysis for design engineers". IEEE, 1995, pgs. 1-7
	X	Natesan, "Performance driven placement for cell-based design". IEEE, 1995, pgs. 237-240.

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.